

**Notice of References Cited**

Application/Control No.

09/423,969

Applicant(s)/Patent Under  
Reexamination  
SEKI ET AL.

Examiner

Anh D. Mai

Art Unit

2814

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
X	A	US-5897328	04-1999	Yamauchi et al.	438	29
X	B	US-5970318	10-1999	Choi et al.	438	99
	C	US-				
	D	US-				
	E	US-				
	F	US-				
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	I	US-				
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	K	US-				
	L	US-				
	M	US-				

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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